



ELECTROSTATIC DISCHARGE (ESD) TESTING REPORT


Applicant/Department: Nations Technologies Inc.	
Product: N32G030K6L7/N32G030K8L7	LOT:
Case NO: S210319134	Quantity: 3 ea
Test Item: CDM	Package/Pin Count: LQFP32
Application Date: 2021/3/19	Date Finished: 2021/3/30
Reference: ESDA/JEDEC JS-002-2018	Temperature: 25 ± 5 °C Humidity: 55 ± 5%
Test Instrument: Orion(SN1612241)	Calibration Due Date: 2020/08/31~2021/08/30
Test Voltage: ±1000V	
Failure Criteria: compliance within 10% V+I envelope around REFERENCE I-V curve (pre-zap) and Customer FunctionTest.	
ESD Testing Result: Minimum Pass Level = ±1000V	

NOTE 1: ESD/latch-up test is employed as one of qualification tests for electronic products. However, the pass / fail results of this test can NOT be taken as go/no-go criteria for IC tape-out and mass production. Before and after ESD/latch-up test(s), complete parametric and functional testing (F/T) are essential for determining pass/fail of the tested products. (References: Page 9, AEC-Q100-003-Rev-E-2003; and Page 15, ESDA-JEDEC JS-001-2017).

NOTE 2: MA-tek sample storage policy is 14 days after the test data delivery. Prolonged storage can be arranged per client's request.

WE HEREBY CERTIFY THAT:

The test(s) was/were conducted according to test conditions provided by customer. Testing was performed on calibrated and JEDEC-ESDA qualified ESD instruments. The quality and comprehensiveness of this test(s) were delivered by qualified personnel.

Tested by	Reviewed by	Approved by
Joe_Xu	Fly-Fei	 Steven Zhu

CERTIFICATE of APPROVAL INDEPENDENT TESTING LABORATORY:

ISO9001:2015 Certificate Registration No. 20001845 QM08, issued by UL DQS Inc.
IEC/IECQ17025 Certificate No. IECQ-L ULTW 09.0009, approved by Certification Body (CB): UL Registered Firm



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1. TEST SUMMARY

[illegible]

* DUT failed at the first level of test condition, defined by client.

NOTE: Red color in raw data indicates failed pins, if any.

**2. Pin ASSIGNMENT**

Pin Group	PAD Pins
VDD	1,17
VSS	16,32
IO	2-15,18-31



3. ESD TEST CONDITIONS

ESD Zap Interval: ≥ 200 ms Zap: 3 pulse.

Testing Combinations

All pins(\pm)

**4. Raw Data - 2**

CDM All pins Test_±1000 (Unit: V)									
Test Pin Fail Voltage		#19	#20	#21	Test Pin Fail Voltage		#19	#20	#21
	VDD	Pass	Pass	Pass		IO	Pass	Pass	Pass
	VSS	Pass	Pass	Pass					

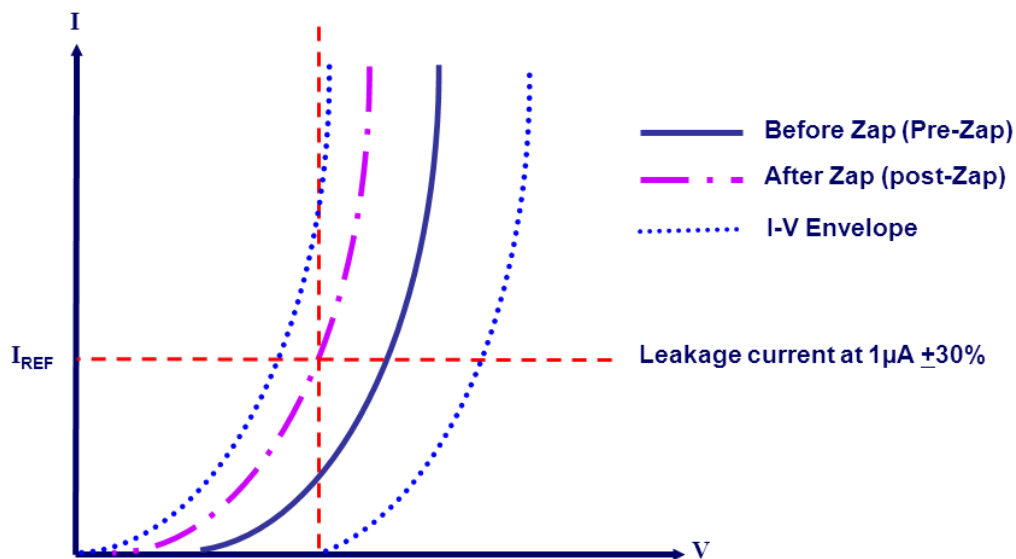
5. APPENDIX-1 (PASS/FAIL CRITERIA)

FAILURE CRITERIA

compliance within 10% V+I envelope around REFERENCE I-V curve (pre-zap) and Customer FunctionTest.

Note

For custom designed ESD testing customers may select variation in I_{dd} , and leakage current as criteria to determine pass/fail results of ESD testing.



Pass/Fail Criteria:

Variation of Leakage Current and I-V Shift in Pre-Zap and Post-Zap curves

6. APPENDIX-2 (ESD INSTRUMENTATION AT MA-TEK)

No.	Test Tools	Vendors	System Specification
1	Zapmaster	Thermo Keytek	256 Pin Count, ESD Pulse 50 V to 8 KV
2	MK1	Thermo Scientific	256 Pin Count, ESD Pulse 10 V to 8 KV
3	MK2	Thermo Keytek	768 Pin Count, ESD Pulse 10 V to 8 KV
4	MK4	Thermo Scientific	2304 Pin Count, ESD Pulse 10 V to 8 KV
5	CDM Tester	Oryx Orion	100 V to 2 KV
6	ESD Gun	Noiseken	Voltage = 1 KV to 30 KV
7	High Temp. Test Module	Thermonics	Maximum temperature = 150°C.
8	TLP Tester	Thermo Scientific	Voltage = 1 V to 2 KV, Current = 10 nA to 40 A





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